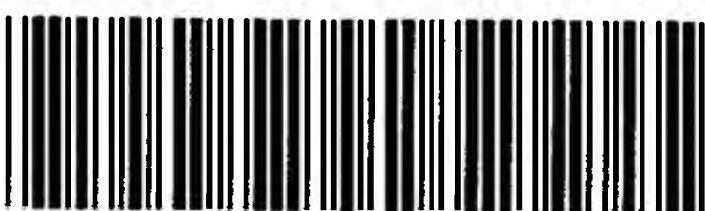


## **S arch Notes**



**Application/C ontrol No.**

10/710 711

## **Examin r**

Joseph D. Pape

**Applicant(s)/Patent under  
Reexamination**

DEFLONG ET AL.

Art Unit

3612

**SEARCHED**

# **SEARCH NOTES (INCLUDING SEARCH STRATEGY)**

## **INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner